

## **Dual N-Channel 60 V (D-S) MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A)	Q <sub>g</sub> (nC) TYP.		
60	1.0 at V <sub>GS</sub> = 10 V	0.55	1.5		
	1.4 at V <sub>GS</sub> = 4.5 V	0.37	1.5		

SOT-323-6

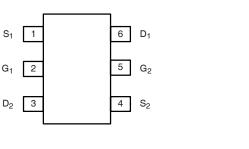
#### **FEATURES**

- DT-Trench Power MOSFET
- 100 % R<sub>g</sub> tested
- PWM Optimized
- Compliant to RoHS Directive 2002/95/EC

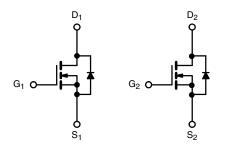
# Pb-free RoHS

#### **APPLICATIONS**

- LED Inverter Circuits
- DC/DC Conversion Circuits
- Motor drives
- · Low power load switch



Top View



N-Channel MOSFET

N-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		0.55		
Continuous Drain Current /T 150 °C\	T <sub>C</sub> = 70 °C		0.42		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	0.34 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		0.27 b, c	А	
Pulsed Drain Current		I <sub>DM</sub>	1.7		
Osalis as a Osasa Baila Bisala Osasal	T <sub>C</sub> = 25 °C		0.55		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	ls =	0.32 b, c	$\neg$	
	T <sub>C</sub> = 25 °C		0.73		
Mariana Danian Disabatian	T <sub>C</sub> = 70 °C		0.47	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.45 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		0.29 b, c	_	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>sta</sub>	-55 to +150	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient b, d	t ≤ 5 s	R <sub>thJA</sub>	300	400	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	210	300	C/VV	

### Notes

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 400 °C/W.



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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		56.7		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			-3			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$			± 100	nA	
Zova Cata Valtaga Dyain Cuyyant		V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			1	μА	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 85 °C			10		
On-State Drain Current a	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	0.55			Α	
Drain-Source On-State Resistance <sup>a</sup>	0	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.2 A		1.0	1.5		
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 0.2 \text{ A}$		1.4	2.0	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.2 A		195		ms	
Dynamic <sup>b</sup>			•	•	•		
Input Capacitance	C <sub>iss</sub>			48.5		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		16			
Reverse Transfer Capacitance	C <sub>rss</sub>			8			
Table Oaks Observe	$Q_g$	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.2 A		1.9	3.4		
Total Gate Charge		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.2 A		1.5	2.5	0	
Gate-Source Charge	$Q_{gs}$		0.3		nC		
Gate-Drain Charge	Q <sub>gd</sub>			0.25		1	
Gate Resistance	$R_g$	f = 1 MHz		160		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			6.5			
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_{L} = 100 \Omega,$		12		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 0.2 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		13			
Fall Time	t <sub>f</sub>			14			
Drain-Source Body Diode Characteris	tics						
Continuous Sorce-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			0.55	А	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				1.7		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 0.2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time				16.5	25	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 0.2 A, dI/dt = 100 A/μs		13	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			13.5	İ	ns	
Reverse Recovery Rise Time	t <sub>b</sub>			3			

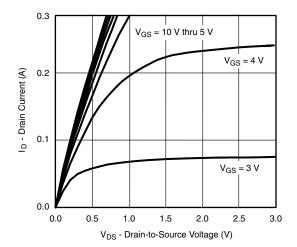
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

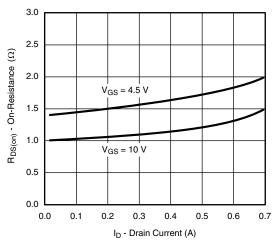
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



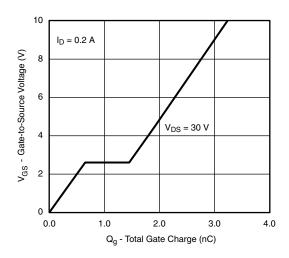
## **TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



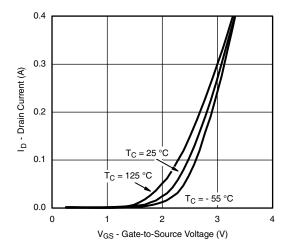
#### **Output Characteristics**



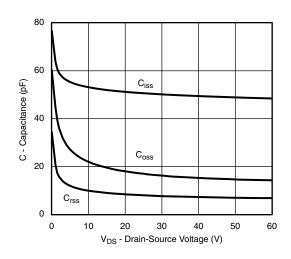
On-Resistance vs. Drain Current



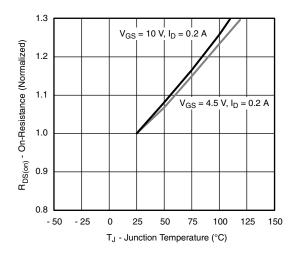
**Gate Charge** 



**Transfer Characteristics Curves vs. Temperature** 



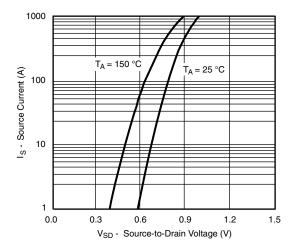
Capacitance



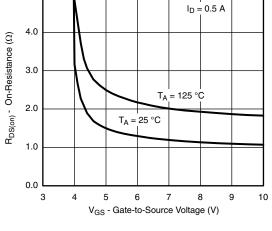
On-Resistance vs. Junction Temperature



## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \, ^{\circ}C$ , unless otherwise noted)

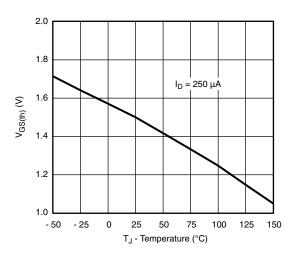


Source-Drain Diode Forward Voltage

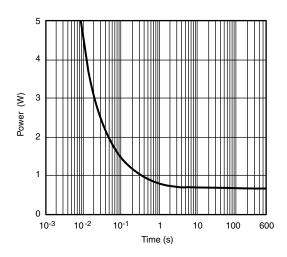


5.0

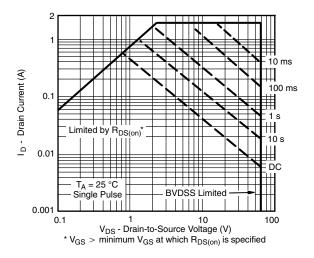
 $R_{DS(on)}\, vs.\, V_{GS}\, vs.\, Temperature$ 



**Threshold Voltage** 



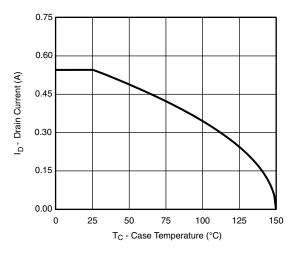
Single Pulse Power

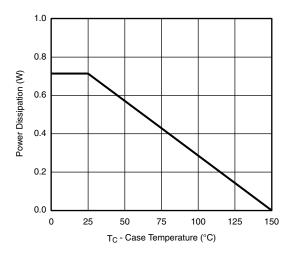


Safe Operating Area



## **TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)





Current Derating a

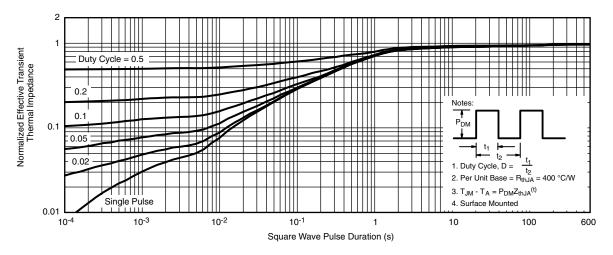
**Power Derating** 

#### Note

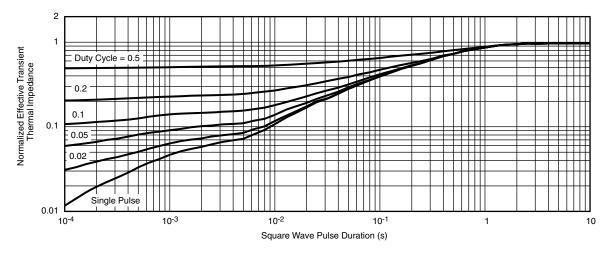
a. The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \, ^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \, ^{\circ}C$ , unless otherwise noted)



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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